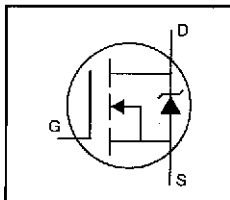


**HEXFET® Power MOSFET**

- Ultra Low Gate Charge
- Reduced Gate Drive Requirement
- Enhanced 30V  $V_{GS}$  Rating
- Isolated Package
- High Voltage Isolation= 2.5KV RMS ⑤
- Sink to Lead Creepage Dist.= 4.8mm
- Repetitive Avalanche Rated



$$V_{DSS} = 400V$$

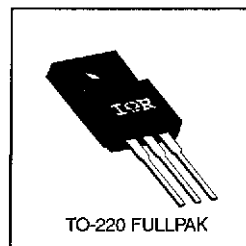
$$R_{DS(on)} = 0.55\Omega$$

$$I_D = 5.7A$$

**Description**

This new series of Low Charge HEXFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing advanced HEXFET technology, the device improvements allow for reduced gate drive requirements, faster switching speeds and increased total system savings. These device improvements combined with the proven ruggedness and reliability that are characteristic of HEXFETs offer the designer a new standard in power transistors for switching applications.

The TO-220 Fullpak eliminates the need for additional insulating hardware. The moulding compound used provides a high isolation capability and low thermal resistance between the tab and external heatsink.


**Absolute Maximum Ratings**

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	5.7	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	3.6	
$I_{DM}$	Pulsed Drain Current ①	23	
$P_D @ T_C = 25^\circ C$	Power Dissipation	40	W
	Linear Derating Factor	0.32	W/°C
$V_{GS}$	Gate-to-Source Voltage	+30	V
$E_{AS}$	Single Pulse Avalanche Energy ②	310	mJ
$I_{AR}$	Avalanche Current ③	5.7	A
$E_{AR}$	Repetitive Avalanche Energy ④	4.0	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$ ③	4.0	V/ns
$T_J$ $T_{STG}$	Operating Junction and Storage Temperature Range	-55 to +150	°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf·in (1.1 N·m)	

**Thermal Resistance**

	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	—	3.1	°C/W
$R_{\theta JA}$	Junction-to-Ambient	—	—	65	

Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	400	—	—	V	$V_{GS}=0\text{V}$ , $I_D=250\mu\text{A}$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.76	—	$^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D=1\text{mA}$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	0.55	$\Omega$	$V_{GS}=10\text{V}$ , $I_D=3.4\text{A}$ ③
$V_{GS(th)}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$
$g_{fs}$	Forward Transconductance	3.0	—	—	S	$V_{DS}=50\text{V}$ , $I_D=6.0\text{A}$ ③
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	25	$\mu\text{A}$	$V_{DS}=400\text{V}$ , $V_{GS}=0\text{V}$
		—	—	250		$V_{DS}=320\text{V}$ , $V_{GS}=0\text{V}$ , $T_J=125^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS}=20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS}=-20\text{V}$
$Q_g$	Total Gate Charge	—	—	39	nC	$I_D=10\text{A}$
$Q_{gs}$	Gate-to-Source Charge	—	—	10		$V_{DS}=320\text{V}$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	—	19		$V_{GS}=10\text{V}$ See Fig. 6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	—	11	—	ns	$V_{DD}=200\text{V}$
$t_r$	Rise Time	—	31	—		$I_D=10\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	25	—		$R_G=9.1\Omega$
$t_f$	Fall Time	—	20	—		$R_D=20\Omega$ See Figure 10 ④
$L_D$	Internal Drain Inductance	—	4.5	—		Between lead, 6 mm (0.25in.) from package and center of die contact
$L_S$	Internal Source Inductance	—	7.5	—		
$C_{iss}$	Input Capacitance	—	1100	—	pF	$V_{GS}=0\text{V}$
$C_{oss}$	Output Capacitance	—	190	—		$V_{DS}=25\text{V}$
$C_{rss}$	Reverse Transfer Capacitance	—	18	—		$f=1.0\text{MHz}$ See Figure 5
C	Drain to Sink Capacitance	—	12	—		$f=1.0\text{MHz}$



## Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	5.7	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{SM}$	Pulsed Source Current (Body Diode) ①	—	—	23		
$V_{SD}$	Diode Forward Voltage	—	—	2.0	V	$T_J=25^\circ\text{C}$ , $I_S=5.7\text{A}$ , $V_{GS}=0\text{V}$ ④
$t_{rr}$	Reverse Recovery Time	—	380	570	ns	$T_J=25^\circ\text{C}$ , $I_F=10\text{A}$
$Q_{rr}$	Reverse Recovery Charge	—	2.8	4.2	$\mu\text{C}$	$di/dt=100\text{A}/\mu\text{s}$ ④
$t_{on}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ )				



## Notes:

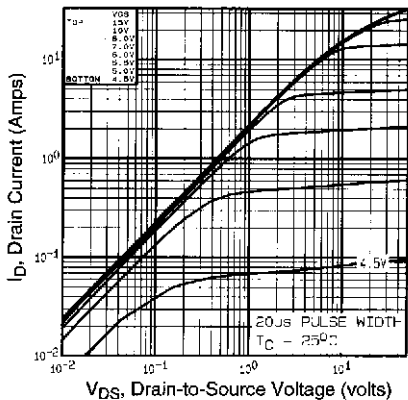
① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)

②  $I_{SD} \leq 10\text{A}$ ,  $di/dt \leq 120\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 150^\circ\text{C}$

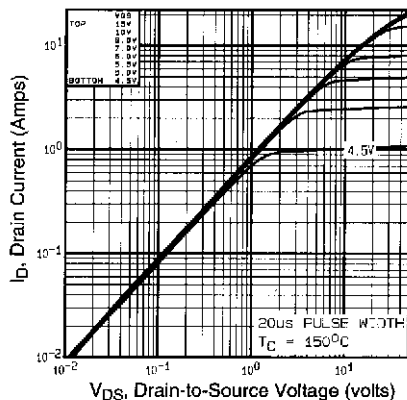
③  $t=60\text{s}$ ,  $f=60\text{Hz}$

④  $V_{DD}=50\text{V}$ , starting  $T_J=25^\circ\text{C}$ ,  $L=16\text{mH}$ ,  $R_G=25\Omega$ ,  $I_{AS}=5.7\text{A}$  (See Figure 12)

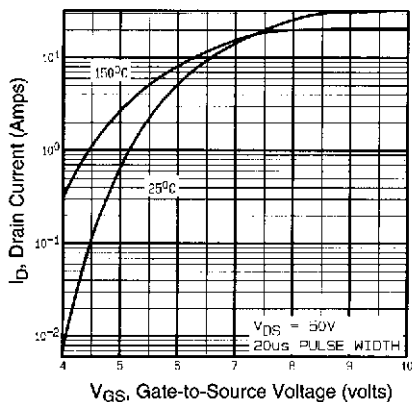
⑤ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .



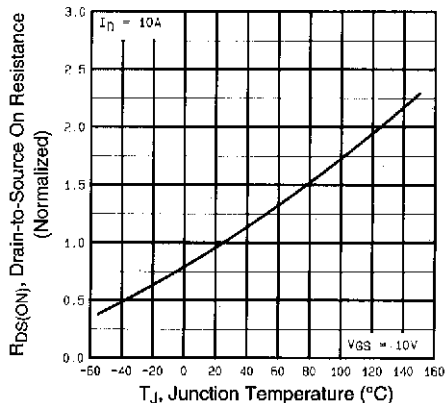
**Fig 1.** Typical Output Characteristics,  
 $T_C = 25^\circ\text{C}$



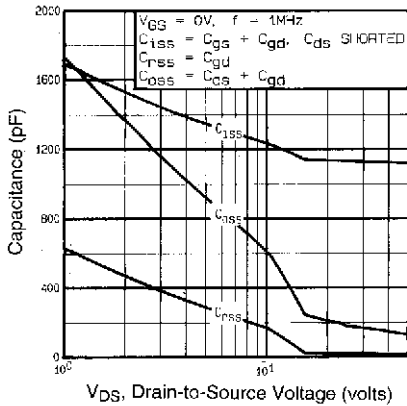
**Fig 2.** Typical Output Characteristics,  
 $T_C = 150^\circ\text{C}$



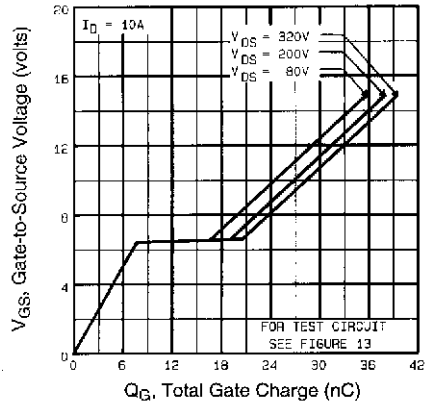
**Fig 3.** Typical Transfer Characteristics



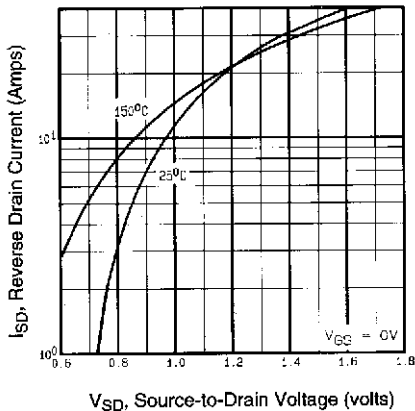
**Fig 4.** Normalized On-Resistance  
Vs. Temperature



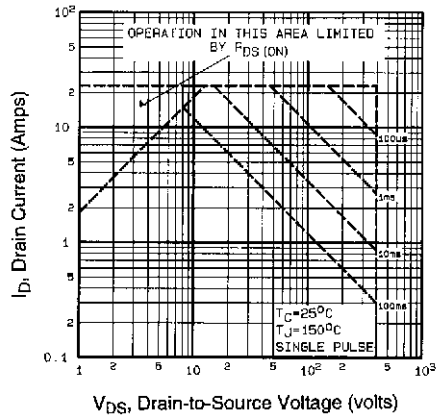
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



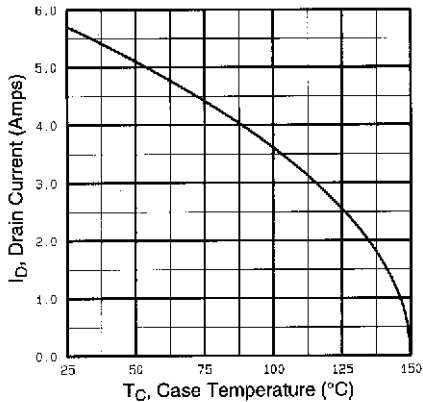
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



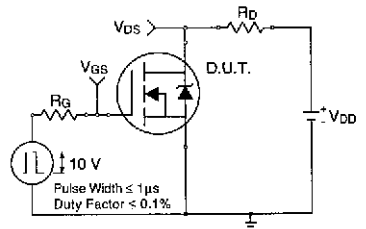
**Fig 7.** Typical Source-Drain Diode Forward Voltage



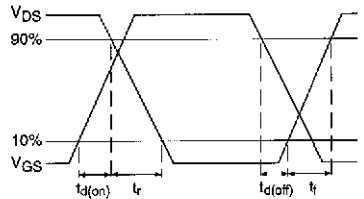
**Fig 8.** Maximum Safe Operating Area



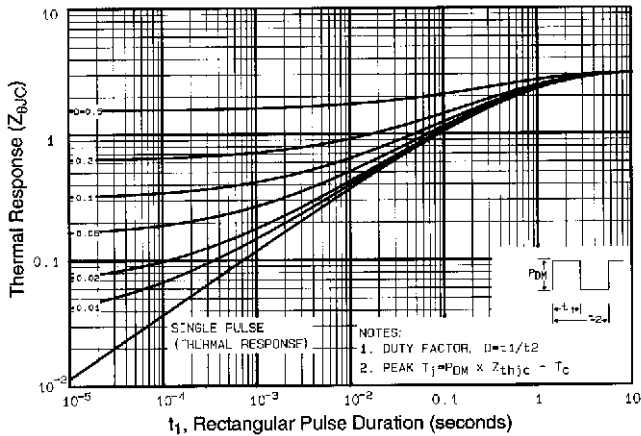
**Fig 9.** Maximum Drain Current Vs. Case Temperature



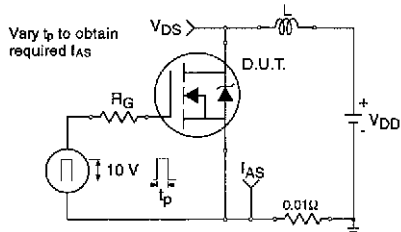
**Fig 10a.** Switching Time Test Circuit



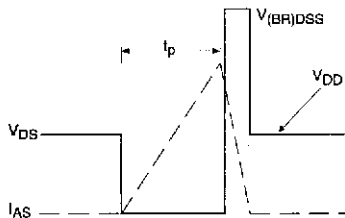
**Fig 10b.** Switching Time Waveforms



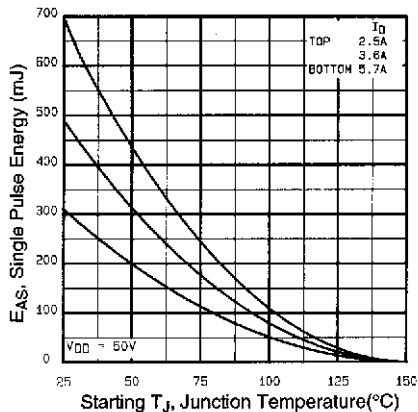
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case



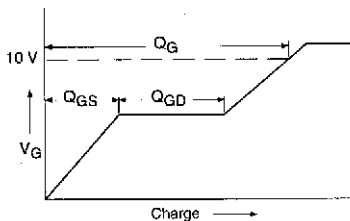
**Fig 12a.** Unclamped Inductive Test Circuit



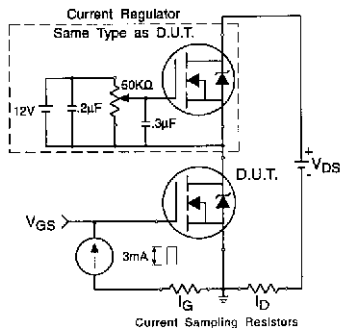
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 13a.** Basic Gate Charge Waveform

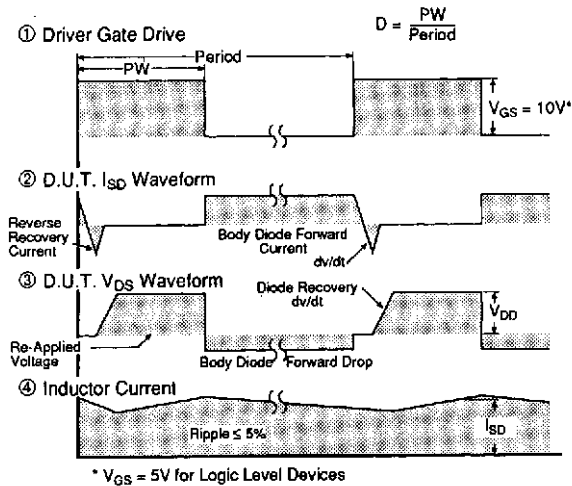
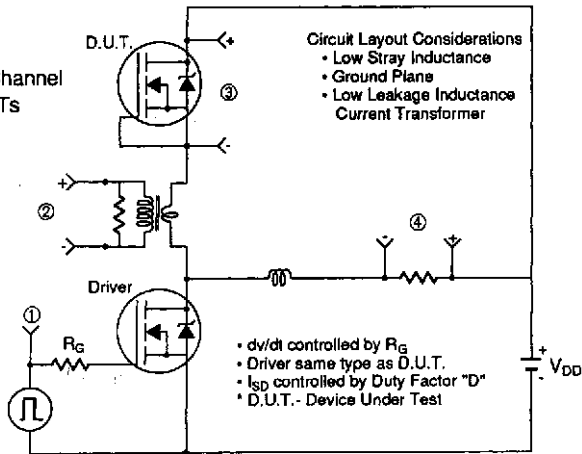


**Fig 13b.** Gate Charge Test Circuit

## Appendix A

## Peak Diode Recovery $dv/dt$ Test Circuit

Fig 14. For N-Channel HEXFETs

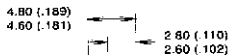
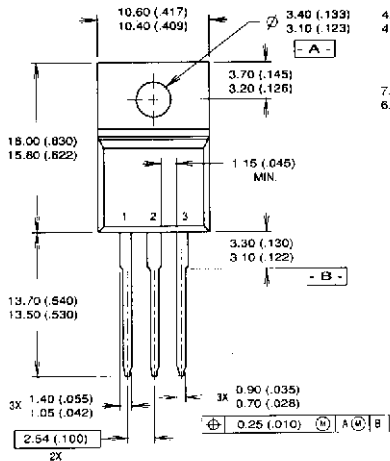


## Package Outline

## Appendix B

### TO-220 FullPak Outline

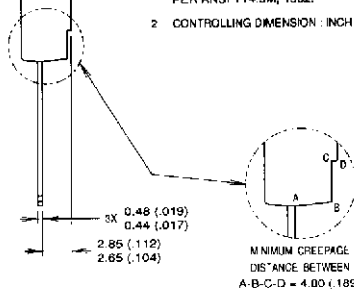
Dimensions are shown in millimeters (inches)



- LEAD ASSIGNMENTS
- 1 - GATE
  - 2 - DRAIN
  - 3 - SOURCE

NOTES

- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.
- 2 CONTROLLING DIMENSION: INCH

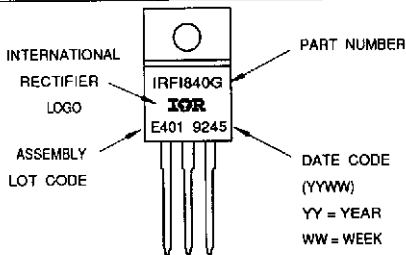


## Part Marking Information

## Appendix C

### TO-220 FULL-PAK

EXAMPLE: THIS IS AN IRF1840G WITH ASSEMBLY LOT CODE E401



Printed on Signet recycled offset: made from 50% recycled waste paper, including 10% de-inked, post-consumer waste.



**International**  
**IR Rectifier**

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EUROPEAN HEADQUARTERS: Hurst Green, Oxted, Surrey RH8 9BB England. Tel: (0883) 713215, Tlx: 95219

IR CANADA: 101 Bentley St., Markham, Ontario L3R 3L1, Tel: (416) 475-1887 IR GERMANY: Saalburgstrasse 157, D-6350 Bad Homburg, Tel: 6172-37065 IR ITALY: Via Liguria 49 10071 Borgaro, Torino, Tel: (011) 470 1464. IR FAR EAST: K&H Building, 30-4 Niahliokukuro 3-Chome, Toshima-ku, Tokyo 171 Japan, Tel: (03) 983 0641. IR SOUTHEAST ASIA: 150 Middle Road, HEX 10-01 Fortune Centre, Singapore 0718, Tel: (65) 336 3922.

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Size and specifications subject to change without notice. (082)





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